

# N-Channel 100 V (D-S) MOSFET

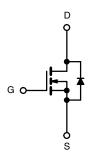
| PRODUCT SUMMARY                                 |        |  |  |  |  |
|---|--------|--|--|--|--|
| V <sub>DS</sub> (V)                             | 100    |  |  |  |  |
| $R_{DS(on)}(\Omega)$ at $V_{GS} = 10 \text{ V}$ | 0. 005 |  |  |  |  |
| I <sub>D</sub> (A) <sup>a</sup>                 | 120    |  |  |  |  |
| Configuration                                   | Single |  |  |  |  |

#### **FEATURES**

- ThunderFET® power MOSFET
- Maximum 175 °C junction temperature
- $\bullet$  100 %  $R_g$  and UIS tested
- Material categorization: for definitions of compliance please see







N-Channel MOSFET

| <b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>C</sub> = 25 °C, unless otherwise noted) |                         |                                   |                  |    |  |  |
|--|-------------------------|-----------------------------------|------------------|----|--|--|
| PARAMETER  | SYMBOL                  | LIMIT                             | UNIT             |    |  |  |
| Drain-Source Voltage   | V <sub>DS</sub>         | 100                               | V                |    |  |  |
| Gate-Source Voltage  | V <sub>GS</sub>         | ± 20                              | V                |    |  |  |
| Continuous Drain Current (T <sub>J</sub> = 150 °C)                               | T <sub>C</sub> = 25 °C  |                                   | 120 <sup>d</sup> |    |  |  |
|  | T <sub>C</sub> = 70 °C  | I <sub>D</sub>                    | 90 q             | A  |  |  |
| Pulsed Drain Current (t = 100 μs)  | I <sub>DM</sub>         | 480                               |                  |    |  |  |
| Avalanche Current  | I <sub>AS</sub>         | 73                                |                  |    |  |  |
| Single Avalanche Energy <sup>a</sup>   | L = 0.1 mH              | E <sub>AS</sub>                   | 266              | mJ |  |  |
| Maximum Power Dissipation <sup>a</sup>   | T <sub>C</sub> = 25 °C  | P <sub>D</sub>                    | 370 b            | W  |  |  |
|  | T <sub>C</sub> = 125 °C | T <sub>D</sub>                    | 120 <sup>b</sup> | VV |  |  |
| Operating Junction and Storage Temperature Range                                 |                         | T <sub>J</sub> , T <sub>stg</sub> | -55 to +175      | °C |  |  |

| THERMAL RESISTANCE RATINGS                   |                   |       |       |  |  |  |
|--|-------------------|-------|-------|--|--|--|
| PARAMETER                                    | SYMBOL            | LIMIT | UNIT  |  |  |  |
| Junction-to-Ambient (PCB Mount) <sup>c</sup> | $R_{thJA}$        | 40    | °C/W  |  |  |  |
| Junction-to-Case (Drain)                     | R <sub>thJC</sub> | 0.4   | - C/W |  |  |  |

#### Notes

- a. Duty cycle  $\leq 1 \%$ .
- b. See SOA curve for voltage derating.
- c. When mounted on 1" square PCB (FR4 material).
- d. Package limited.

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| PARAMETER                                     | SYMBOL              | TEST CONDITIONS   | MIN. | TYP.  | MAX.  | UNIT |  |
|---|---------------------|---|------|-------|-------|------|--|
| Static  |                     |   |      | 1     |       |      |  |
| Drain-Source Breakdown Voltage                | V <sub>DS</sub>     | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$                           | 100  | -     | -     | V    |  |
| Gate Threshold Voltage                        | V <sub>GS(th)</sub> | $V_{DS} = V_{GS}, I_D = 250 \mu A$                                      | 2.5  | -     | 4     |      |  |
| Gate-Body Leakage                             | I <sub>GSS</sub>    | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$                       | -    | -     | ± 250 | nA   |  |
|   |                     | V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V                          | -    | -     | 1     | μА   |  |
| Zero Gate Voltage Drain Current               | I <sub>DSS</sub>    | V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C | -    | -     | 150   |      |  |
|   |                     | V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 175 °C | -    | -     | 5     | mA   |  |
| On-State Drain Current <sup>a</sup>           | I <sub>D(on)</sub>  | $V_{DS} \ge 10 \text{ V}, V_{GS} = 10 \text{ V}$                        | 120  | -     | -     | Α    |  |
|   | D                   | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A                           | -    | 0.005 | -     | Ω    |  |
| Drain-Source On-State Resistance <sup>a</sup> | R <sub>DS(on)</sub> | V <sub>GS</sub> = 7.5 V, I <sub>D</sub> = 15 A                          | -    | 0.006 | -     |      |  |
| Forward Transconductance <sup>a</sup>         | 9 <sub>fs</sub>     | V <sub>DS</sub> = 15 V, I <sub>D</sub> = 20 A                           | -    | 82    | -     | S    |  |
| Dynamic <sup>b</sup>                          |                     |   |      | •     |       |      |  |
| Input Capacitance                             | C <sub>iss</sub>    | V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 50 V, f = 1 MHz                | -    | 10000 | -     | pF   |  |
| Output Capacitance                            | C <sub>oss</sub>    |   | -    | 2025  | -     |      |  |
| Reverse Transfer Capacitance                  | C <sub>rss</sub>    |   | -    | 165   | -     |      |  |
| Total Gate Charge <sup>c</sup>                | Qg                  |   | -    | 76    | 120   |      |  |
| Gate-Source Charge <sup>c</sup>               | $Q_{gs}$            | $V_{DS} = 50 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$      | -    | 23    | -     | nC   |  |
| Gate-Drain Charge <sup>c</sup>                | $Q_{gd}$            |   | -    | 17    | -     | 1    |  |
| Gate Resistance                               | $R_g$               | f = 1 MHz   | 0.6  | 3.3   | 6.6   | Ω    |  |
| Turn-On Delay Time <sup>c</sup>               | t <sub>d(on)</sub>  |   | -    | 15    | 30    |      |  |
| Rise Time <sup>c</sup>                        | t <sub>r</sub>      | $V_{DD} = 50 \text{ V}, R_{I} = 5 \Omega$                               | -    | 22    | 40    |      |  |
| Turn-Off Delay Time <sup>c</sup>              | t <sub>d(off)</sub> | $I_D\cong 10~A,~V_{GEN}=10~V,~R_g=1~\Omega$                             | -    | 55    | 100   | ns   |  |
| Fall Time <sup>c</sup>                        | t <sub>f</sub>      |   | -    | 15    | 30    |      |  |
| Drain-Source Body Diode Ratings ar            | nd Characteri       | stics <sup>b</sup> (T <sub>C</sub> = 25 °C)                             |      |       |       |      |  |
| Pulsed Current                                | I <sub>SM</sub>     |   | -    | -     | 480   | Α    |  |
| Forward Voltage <sup>a</sup>                  | $V_{SD}$            | I <sub>F</sub> = 10 A, V <sub>GS</sub> = 0 V                            | -    | 0.8   | 1.5   | V    |  |

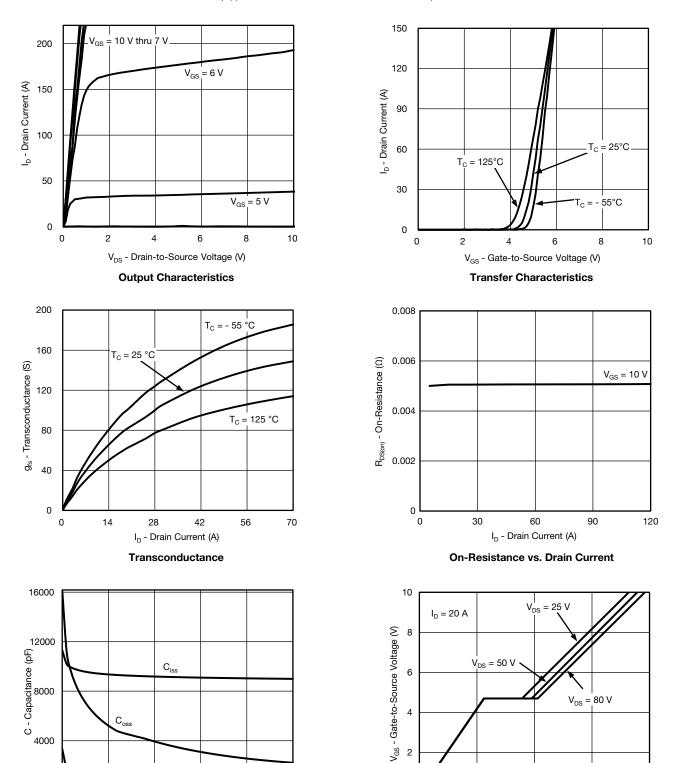
#### **Notes**

- a. Pulse test; pulse width  $\leq 300~\mu s,~duty~cycle \leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



## TYPICAL CHARACTERISTICS (T<sub>A</sub> = 25 °C, unless otherwise noted)



2

0

0

100

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20

40

 $V_{\rm DS}$  - Drain-to-Source Voltage (V)

Capacitance

80

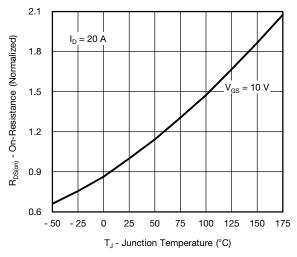
60

Q<sub>q</sub> - Total Gate Charge (nC)

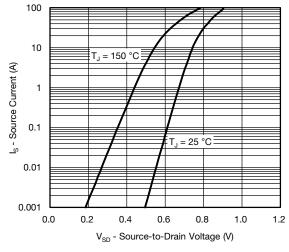
**Gate Charge** 



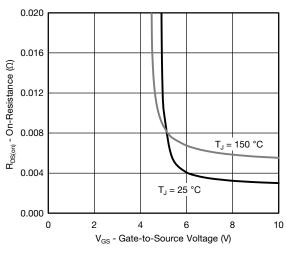
## TYPICAL CHARACTERISTICS (T<sub>A</sub> = 25 °C, unless otherwise noted)



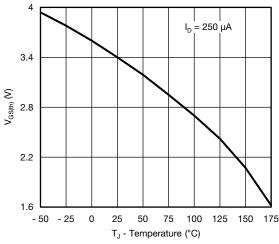
On-Resistance vs. Junction Temperature



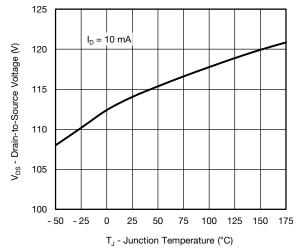
**Source Drain Diode Forward Voltage** 



On-Resistance vs. Gate-to-Source Voltage



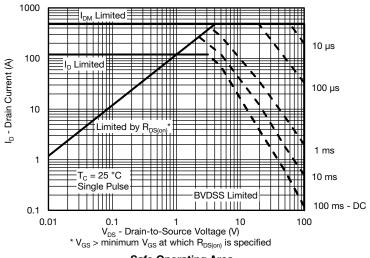
**Threshold Voltage** 



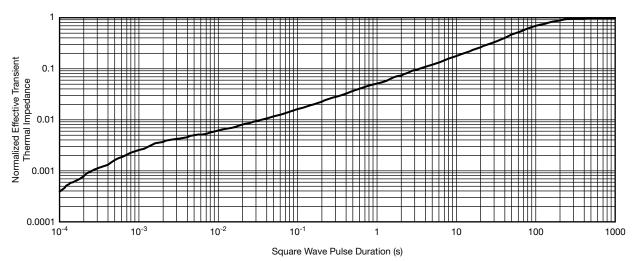
Drain Source Breakdown vs. Junction Temperature



## **THERMAL RATINGS** ( $T_A = 25$ °C, unless otherwise noted)



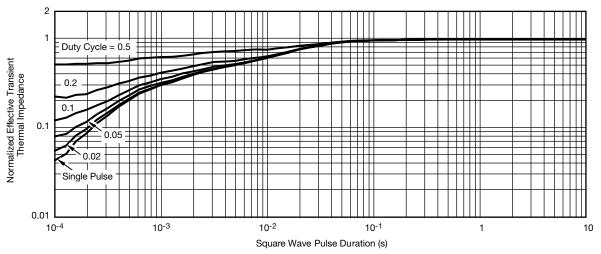
Safe Operating Area



Normalized Thermal Transient Impedance, Junction-to-Ambient



### THERMAL RATINGS (T<sub>A</sub> = 25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Case

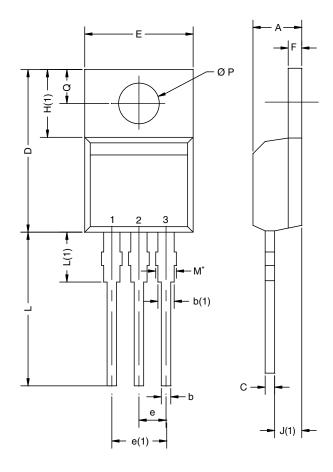
#### Note

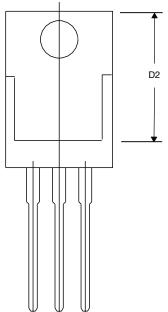
- The characteristics shown in the two graphs
  - Normalized Transient Thermal Impedance Junction to Ambient (25 °C)
  - Normalized Transient Thermal Impedance Junction to Case (25 °C)

are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board - FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions.



## **TO-220AB**





|  | MILLIM | IETERS | INCHES |       |  |
|--|--------|--------|--------|-------|--|
| DIM.   | MIN.   | MAX.   | MIN.   | MAX.  |  |
| А  | 4.25   | 4.65   | 0.167  | 0.183 |  |
| b  | 0.69   | 1.01   | 0.027  | 0.040 |  |
| b(1)   | 1.20   | 1.73   | 0.047  | 0.068 |  |
| С  | 0.36   | 0.61   | 0.014  | 0.024 |  |
| D  | 14.85  | 15.49  | 0.585  | 0.610 |  |
| D2   | 12.19  | 12.70  | 0.480  | 0.500 |  |
| E  | 10.04  | 10.51  | 0.395  | 0.414 |  |
| е  | 2.41   | 2.67   | 0.095  | 0.105 |  |
| e(1)   | 4.88   | 5.28   | 0.192  | 0.208 |  |
| F  | 1.14   | 1.40   | 0.045  | 0.055 |  |
| H(1)   | 6.09   | 6.48   | 0.240  | 0.255 |  |
| J(1)   | 2.41   | 2.92   | 0.095  | 0.115 |  |
| L  | 13.35  | 14.02  | 0.526  | 0.552 |  |
| L(1)   | 3.32   | 3.82   | 0.131  | 0.150 |  |
| ØΡ   | 3.54   | 3.94   | 0.139  | 0.155 |  |
| Q  | 2.60   | 3.00   | 0.102  | 0.118 |  |
| ECN: T14-0413-Rev. P, 16-Jun-14<br>DWG: 5471 |        |        |        |       |  |

### Note

 $^{\star}$  M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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DMN2080UCB4-7 DMN61D9UWQ-13 US6M2GTR DMN31D5UDJ-7 DMP22D4UFO-7B DMN1006UCA6-7 DMN16M9UCA6-7
STF5N65M6 IRF40H233XTMA1 STU5N65M6 DMN6022SSD-13 DMN13M9UCA6-7 DMTH10H4M6SPS-13 DMN2990UFB-7B
IPB80P04P405ATMA2 2N7002W-G MCAC30N06Y-TP MCQ7328-TP BXP7N65D BXP4N65F AOL1454G WMJ80N60C4 BXP2N20L
BXP2N65D BXT1150N10J BXT1700P06M TSM60NB380CP ROG RQ7L055BGTCR DMNH15H110SK3-13 SLF10N65ABV2
BSO203SP BSO211P IPA60R230P6 IPA60R460CE